Search Notes

/	Appli	cation/	Contro	No.

Applicant(s)/Patent under Reexamination

10/621,030

KIRSCH ET AL.

Examiner

2685

SIMON D. NGUYEN

SEARCHED					
Class	Subclass	Date	Examiner		
455	136	12/14/2005	SDN		
	182.2				
	192.2				
	257,258	·			
	63.1,71				
375	344				
	148				
	-				

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
AS	ABOVE	11/14/2005	SDN			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	12/14/2005	SDN		